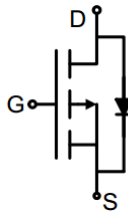
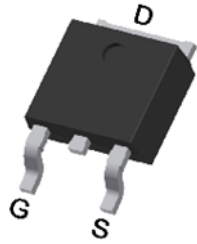


P-Channel Enhancement Mode Power MOSFET

Description The G12P06K uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge. It can be used in a wide variety of applications.		 Schematic diagram	
General Features • V_{DS} -60V • I_D (at $V_{GS} = -10V$) -12A • $R_{DS(ON)}$ (at $V_{GS} = -10V$) < 75mΩ • $R_{DS(ON)}$ (at $V_{GS} = -4.5V$) < 120mΩ • 100% Avalanche Tested • RoHS Compliant		 TO-252	
Application • Power switch • DC/DC converters			
Device	Package	Marking	Packaging
G12P06K	TO-252	G12P06	2500pcs/Reel

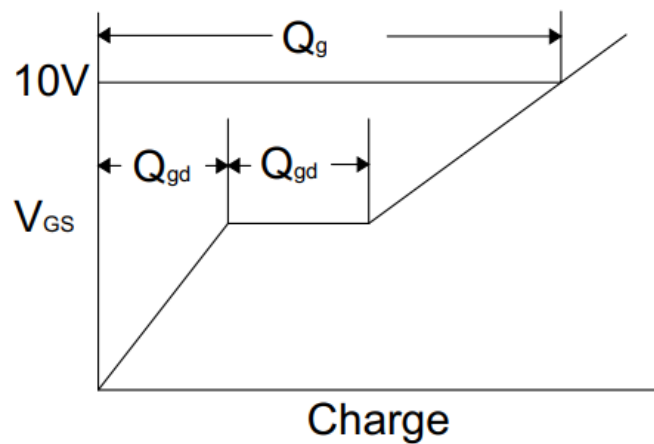
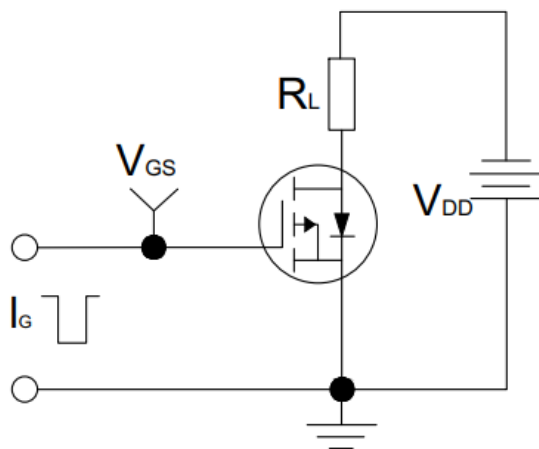
Absolute Maximum Ratings $T_C = 25^\circ\text{C}$, unless otherwise noted			
Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	-60	V
Continuous Drain Current	I_D	-12	A
Pulsed Drain Current (note1)	I_{DM}	-48	A
Gate-Source Voltage	V_{GS}	± 20	V
Single pulse avalanche energy (note3)	E_{AS}	60	mJ
Power Dissipation	P_D	27	W
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 To 150	$^\circ\text{C}$
Thermal Resistance			
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	R_{thJC}	4.68	$^\circ\text{C/W}$

Specifications T _J = 25°C, unless otherwise noted						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
Static Parameters						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = -250μA	-60	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -60V, V _{GS} = 0V	--	--	-1	uA
Gate-Source Leakage	I _{GSS}	V _{GS} = ±20V	--	--	±100	nA
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250μA	-1.0	-1.5	-3	V
Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -10V, I _D = - 6A	--	56	75	mΩ
		V _{GS} = -4.5V, I _D = - 5A	--	68	120	
Forward Transconductance	g _{FS}	V _{DS} =10V,I _D =-6A	--	15	--	S
Dynamic Parameters						
Input Capacitance	C _{ISS}	V _{GS} = 0V, V _{DS} = -30V, f = 1.0MHz	--	1108	--	pF
Output Capacitance	C _{OSS}		--	74	--	
Reverse Transfer Capacitance	C _{rSS}		--	58	--	
Total Gate Charge	Q _g	V _{DD} = -30V, I _D = -6A, V _{GS} = -10V	--	23	--	nC
Gate-Source Charge	Q _{gs}		--	4	--	
Gate-Drain Charge	Q _{gd}		--	5	--	
Turn-on Delay Time	t _{d(on)}	V _{DD} = -30V, I _D = -6A, R _G = 3Ω	--	8	--	ns
Turn-on Rise Time	t _r		--	4	--	
Turn-off Delay Time	t _{d(off)}		--	32	--	
Turn-off Fall Time	t _f		--	7	--	
Drain-Source Body Diode Characteristics						
Continuous Body Diode Current	I _S	T _C = 25°C	--	--	-12	A
Body Diode Voltage	V _{SD}	T _J = 25°C, I _{SD} = -6A, V _{GS} = 0V	--	--	-1.2	V
Reverse Recovery Time	T _{rr}	I _S = -8A, V _{GS} = 0V di/dt=-100A/us	--	25	--	ns
Reverse Recovery Charge	Q _{rr}		--	31	--	nc

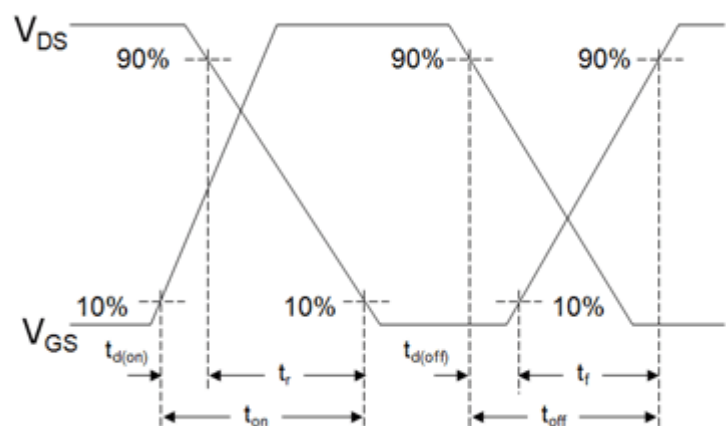
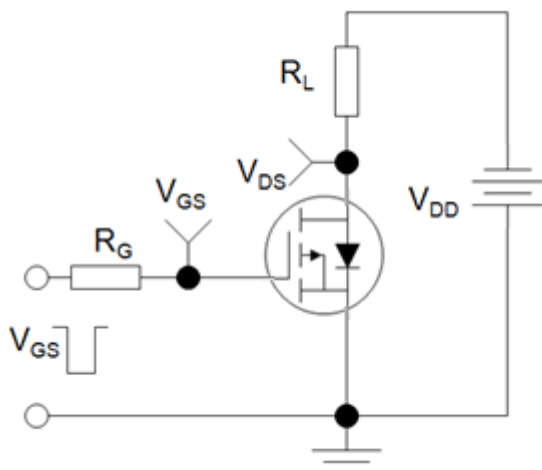
Notes

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. Identical low side and high side switch with identical R_G
3. EAS condition : $T_J=25^{\circ}\text{C}$, $V_{DD}=-50V, V_{GS}=-10V, L=0.5\text{mH}, R_g=25\Omega$

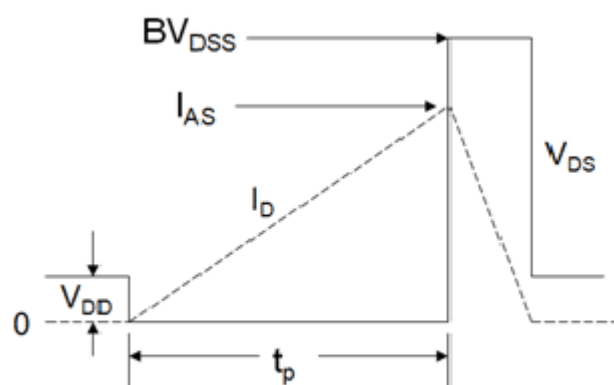
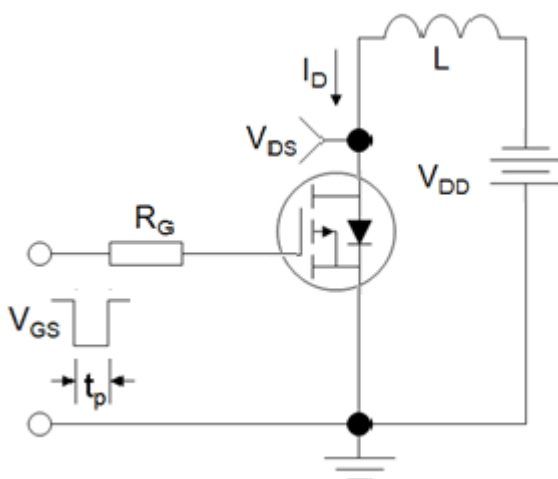
Gate Charge Test Circuit



Switch Time Test Circuit



EAS Test Circuit



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Figure 1. Output Characteristics

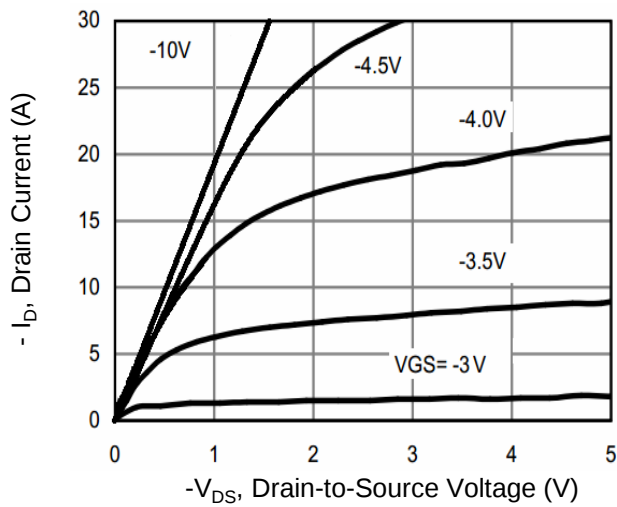


Figure 2. Transfer Characteristics

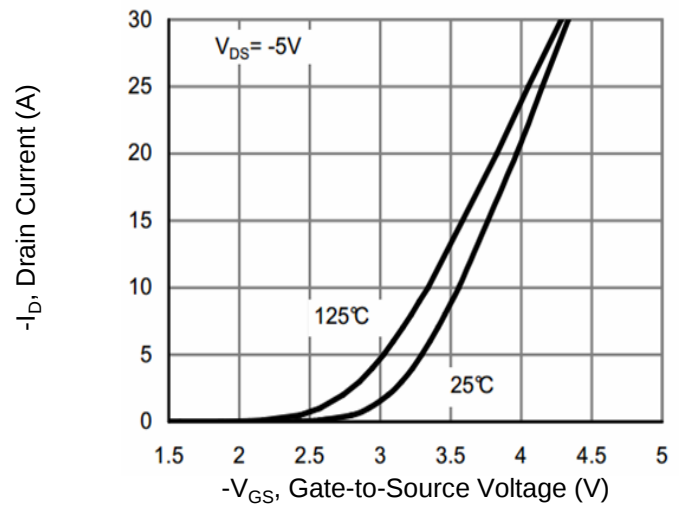


Figure 3. Gate Charge

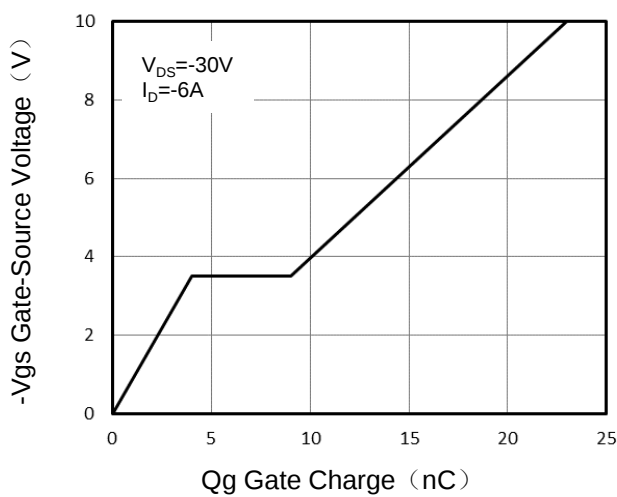


Figure 4. Drain Source On Resistance

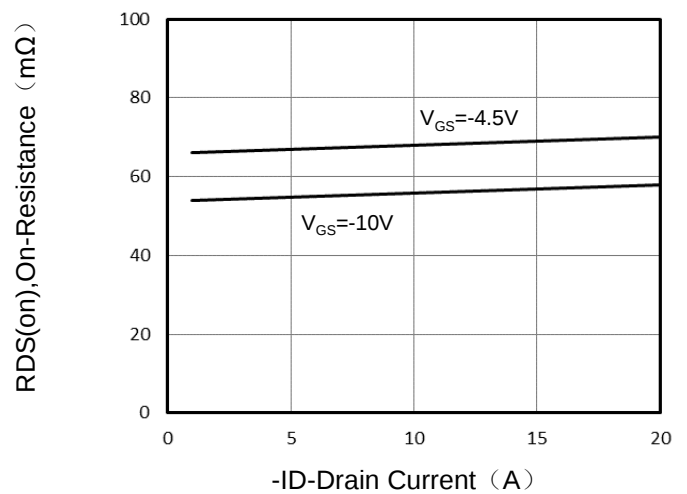


Figure 5. Capacitance

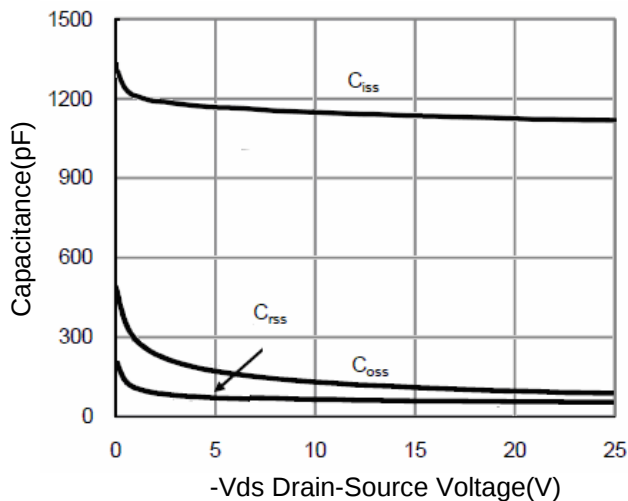
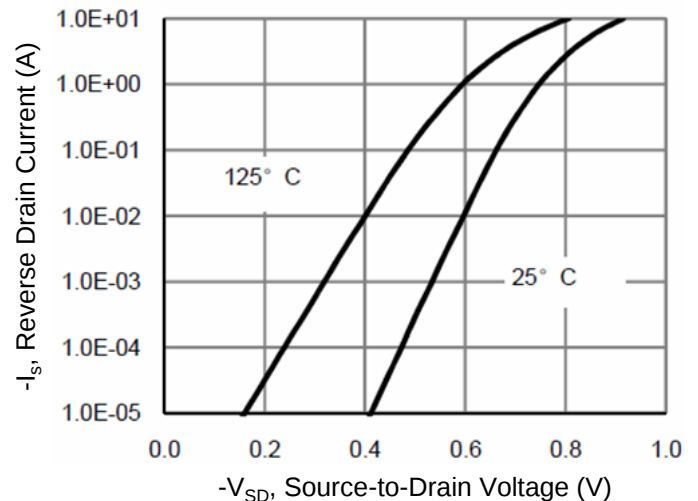


Figure 6. Source-Drain Diode Forward



Typical Characteristics $T_J = 25^\circ\text{C}$, unless otherwise noted

Figure 7. Drain-Source On-Resistance

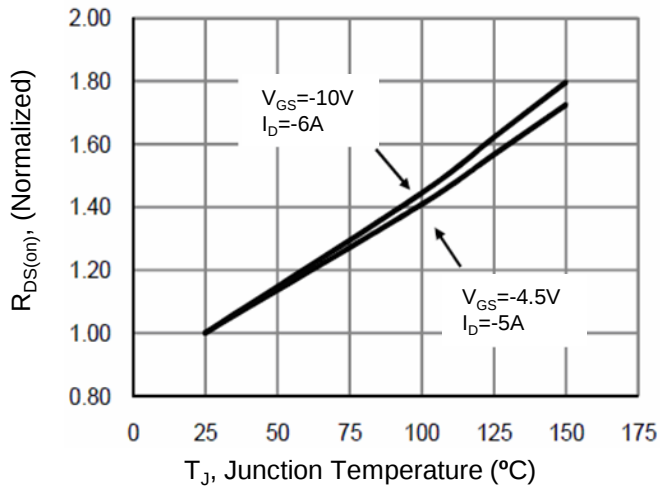


Figure 8. Safe Operation Area

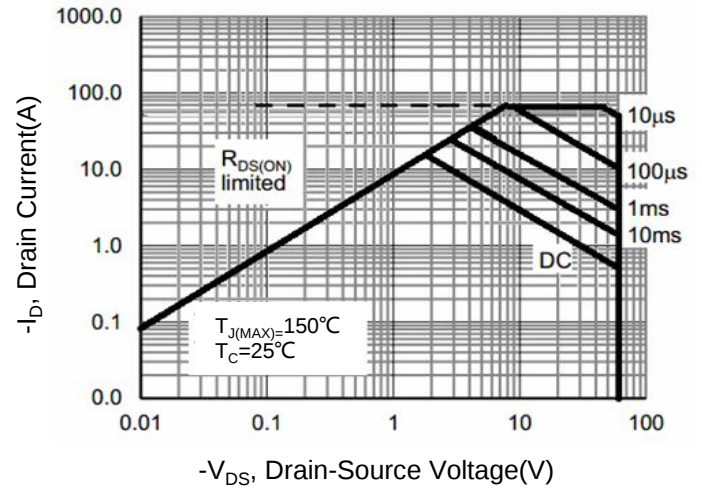
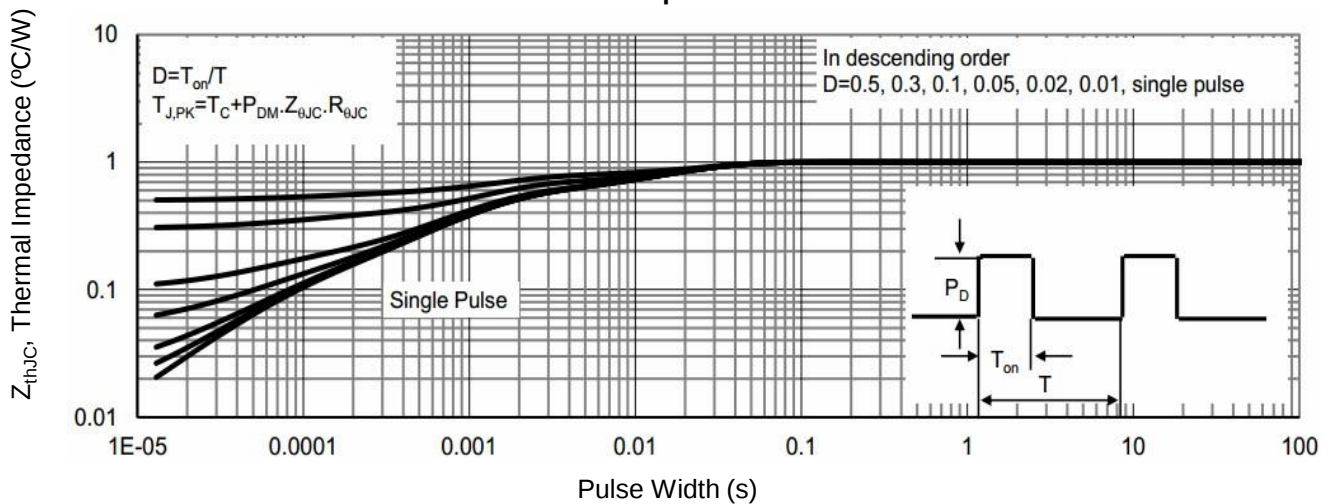
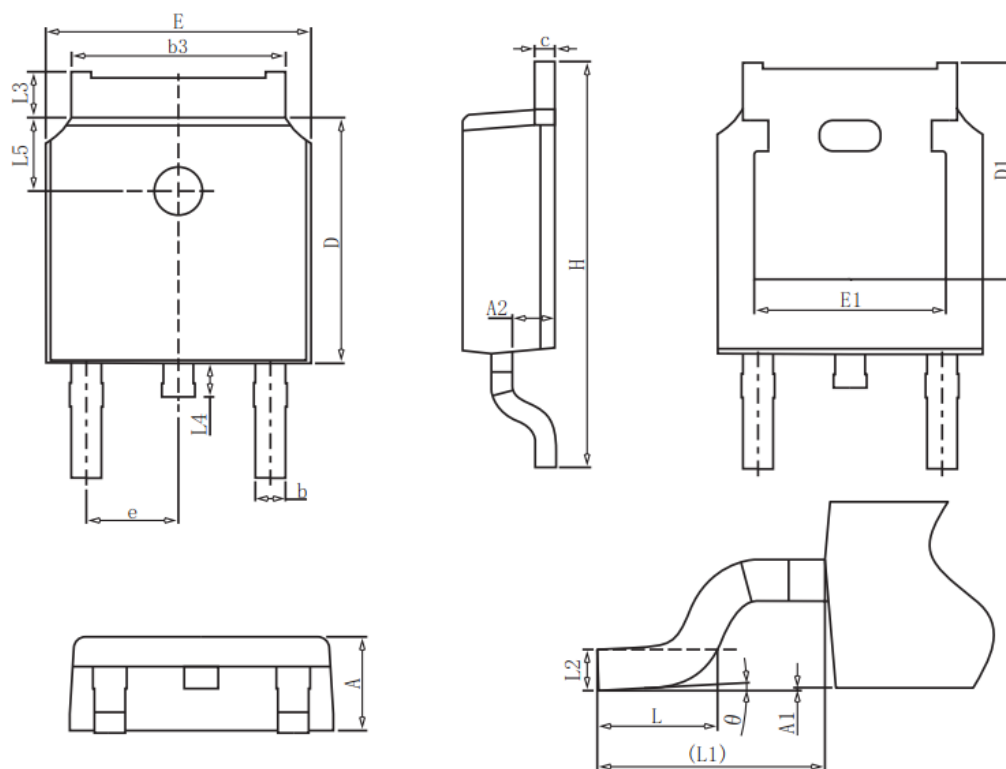


Figure 9. Normalized Maximum Transient Thermal Impedance



TO-252 Package Information



Symbol	Dimensions in Millimeters		
	MIN.	NOM.	MAX.
A	2.2	2.3	2.4
A1	0		0.2
A2	0.97	1.07	1.17
b	0.68	0.78	0.9
b3	5.2	5.33	5.5
c	0.43	0.53	0.63
D	5.98	6.1	6.22
D1	5.30REF		
E	6.4	6.6	6.8
E1	4.63		
e	2.286BSC		
H	9.4	10.1	10.5
L	1.38	1.5	1.75
L1	2.90REF		
L2	0.51BSC		
L3	0.88		1.28
L4	0.5		1
L5	1.65	1.8	1.95
θ	0°		8°